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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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patent application of:)	Before the Examiner
David W. Burke et al.)	
)	Not Yet Assigned
Serial No. 10/688,561)	
)	Group Art Unit 3736
Filed October 17, 2003)	
OVERTION FOR)	
SYSTEM AND METHOD FOR)	
DETERMINING AN ABUSED SENSOR)	7. 44.0005
DURING ANALYTE MEASUREMENT)	February 11, 2005

INFORMATION DISCLOSURE STATEMENT

MAIL STOP AMENDMENT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure in accordance with 37 C.F.R. §1.56, Applicant wishes to bring to the attention of the Examiner the items of information listed on the enclosed Information Disclosure Citation Form. This information has not been previously submitted in this application, and has not been heretofore cited previously by the Examiner. Copies of all foreign patent documents and non-patent literature are enclosed in accordance with 37 CFR 1.98(a). Copies of cited U.S. patents and patent applications are not enclosed pursuant to 37 CFR 1.491(b).

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on

February 11, 2005

Date of Deposit

Troy J. Cole

Name of Registered Representative

Signature

February 11, 2005

Date of Signature

For items of information contained in this Statement that are not in the English language, under §1.98(a)(3)(i) these items are understood to be relevant in that they relate to biosensors and were included in the results of searches conducted on behalf of Applicants.

The filing of this Information Disclosure Statement shall not be construed as an admission that the information cited is, or is considered to be, material to patentability as defined in §1.56(b).

This Statement is being submitted prior to the mailing of any Office Action on the merits. It is believed that no fee is required for consideration of the submitted items. However, should any fees be deemed required, the Commissioner is authorized to charge such fees to Deposit Account No. 23-3030, but is not to include payment of issue fees.

Respectfully submitted

Bv:

Troy J Cole

Reg. No. 35,102

Woodard, Emhardt, Moriarty,

McNett & Henry LLP

Bank One Center/Tower

111 Monument Circle, Suite 3700

Indianapolis, Indiana 46204-5137

(317) 634-3456

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Substitute for form 1449ATH		Complete if Known
Substitute for form 1449AP+O	Application Number	10/688,561
INFORMATION DISCLOSURE	Filing Date	October 17, 2003
STATEMENT BY APPLICANT	First Named Inventor	David W. Burke
,	Group Art Unit	Complete if Known 10/688,561 October 17, 2003 Or David W. Burke 3736
(use as many sheets as necessary)	Examiner Name	
Chart 4 of 38	Attorney Docket Number	7404-556

			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
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		3,621,381	11/16/1971	Eckfeldt	
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		AU 737 787	08/30/2001	Batman et al.		
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		DE 199 36 693	02/08/2001	LRE		$oxed{oxed}$
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		EP 0 034 049	08/19/1981	Columbus		<u> </u>
		EP 0 057 110	08/04/1982	Columbus		

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Substitute for form 1449A/PTO		Application Number	10/688,561				
	ORMATION			Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	Sheet 2 of 38		Attornev Docket Number	7404-556			

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Date Considered

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Substitute for form 1449A/PTO		Application Number	10/688,561				
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	3	of	38	Attornev Docket Number	7404-556		

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Examiner Cite No.1	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant		
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		EP 0 287 883	10/26/1988	Blatt		

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Signature	Considered
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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,561		
INFO	RMATION I	DISC	LOSURE	Filing Date	October 17, 2003		
STAT	TEMENT BY	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	4	of	38	Attornev Docket Number	7404-556		

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Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
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		EP 0 359 831	03/28/1990	Nankai et al.		
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Examiner Signature Date Considered	

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INF	ORMATION I	DISC	LOSURE	Filing Date	October 17, 2003		
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
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Sheet	5	of	38	Attornev Docket Number	7404-556		

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		4,834,234	05/30/1989	Sacherer et al.					
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				Complete if Known			
Substitute for form 1449A/PTO				Application Number	10/688,561		
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STAT	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	8	of	38	Attornev Docket Number	7404-556		

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INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
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				Group Art Unit	3736		
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Sheet	9	of	38	Attornev Docket Number	7404-556		

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	ORMATION			Filing Date	October 17, 2003	
ST	ATEMENT E	BY APP	LICANT	First Named Inventor	David W. Burke	
				Group Art Unit	3736	
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Sheet	10	of	38	Attornev Docket Number	7404-556	

Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	т•
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Substitute fo	or form 1449A/	PIO		Application Number	10/688,561	
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003	
STAT	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke	
				Group Art Unit	3736	
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Sheet	11	of	38	Attornev Docket Number	7404-556	

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Substitute	e for form 1449A/P	OTr		Application Number	10/688,561		
INFO	ORMATION [DISC	LOSURE	Filing Date	October 17, 2003		
	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	12	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS	Pages, Columns, Lines where
Examiner	Cite	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Relevant Passages or Relevant
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				Group Art Unit	3736		
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Initials* N	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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		WO 92/15859	09/17/1992	Adrian et al.		
		WO 92/15861	09/17/1992	Grant et al.		

Examiner Signature	Date Considered	

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WEMMH/SB/08A (4/03)

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				Complete if Known				
Substitute for form 1449A/PTO				Application Number	10/688,561			
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003			
STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke			
	_			Group Art Unit	3736			
(1	use as many she	ets as r	ecessary)	Examiner Name				
Sheet	15	of	38	Attornev Docket Number	7404-556			

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Examiner Cite Initials* No.1	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	NO.	Number-Kind Code ² (If known)	MINI-DD-1111		Figures Appear
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	mm-DD-1111	Document	Figures Appear	Ļ
		WO 92/15950	09/17/1992	Arbuckle et al.		
		WO 92/22669	12/23/1992	Gullick		
		WO 93/09433	05/13/1993	Gharib		
		WO 94/12950	06/09/1994	Holmes et al.		
		WO 94/16095	07/21/1994	Zweig		
		WO 94/23295	10/13/1994	McAleer et al.		
		WO 94/28414	12/08/1994	Athey et al.		
		WO 94/29705	12/22/1994	White et al.		

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Substitute	e for form 1449A/F	10		Application Number	10/688,561
**	INFORMATION DISCLOSURE		Filing Date	October 17, 2003	
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke
_			Group Art Unit	3736	
(1	(use as many sheets as necessary)		Examiner Name		
Sheet	16	of	38	Attornev Docket Number	7404-556

Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	And the property of Cited Description		Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear	
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	$oxed{oxed}$
		WO 95/03542	02/02/1995	Scott et al.		
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		WO 96/13707	05/09/1996	Connolly		
-		WO 96/15454	05/23/1996	Braach-		

Examiner Signature	Date Considered	

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Complete if Known Substitute for form 1449A/PTO 10/688,561 **Application Number** INFORMATION DISCLOSURE Filing Date October 17, 2003 STATEMENT BY APPLICANT David W. Burke First Named Inventor 3736 **Group Art Unit** (use as many sheets as necessary) **Examiner Name** 7404-556 Attornev Docket Number 38 of Sheet

			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 96/33403	10/24/1996	Higson		
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		WO 97/02487	01/23/1997	Pritchard et al.		
		WO 97/08544	03/06/1997	Wojciechowski		$oldsymbol{ol}}}}}}}}}}}}}}}}}}$
		WO 97/16726	05/09/1997	Sullivan		
		WO 97/18465	05/22/1997	Hodges et al.		$oldsymbol{ol}}}}}}}}}}}}}}}}}$
		WO 97/29366	08/14/1997	Braach-		
		WO 97/29847	08/21/1997	McAleer et al.		

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Signature	Considered
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Substitute	Substitute for form 1449A/PTO			Application Number	10/688,561		
INF	INFORMATION DISCLOSURE		Filing Date	October 17, 2003			
ST	ATEMENT B	Y APF	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
(use as many shee	ets as ne	cessary)	Examiner Name			
Sheet	18	of	38	Attornev Docket Number	7404-556		

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant
Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 97/30344	08/21/1997	McAleer et al.		
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		WO 98/05424	02/12/1998	Chow		
		WO 98/19153	05/07/1998	Vadgama et al.		

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Substitute for form 1449A/PTO				Application Number	10/688,561			
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003	_		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke			
				Group Art Unit	3736			
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Sheet	19	of	38	Attornev Docket Number	7404-556	J		

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Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Relevant Passages or Relevant	
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 98/19159	05/07/1998	Douglas et al.		
		WO 98/29740	07/09/1998	Clerc et al.		
		WO 98/35225	08/13/1998	Heller et al.		
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		WO 99/05966	02/11/1999	Alton et al.		
		WO 99/09404	02/25/1999	Maxwell et al.		

Examiner Signature	Date Considered	

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		(DTO		Complete if Known			
Substitute to	Substitute for form 1449A/PTO			Application Number	10/688,561		
INFO	RMATION	I DISCI	OSURE	Filing Date	October 17, 2003		
STAT	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
_				Group Art Unit	3736		
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Sheet	20	of	38	Attornev Docket Number	7404-556		

	_		U.S. PATEN	T DOCUMENTS	
Examiner	Cite	Document Number	Pages, Columns, Lines where Relevant Passages or Relevant		
initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials* No.1		Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/12008	03/11/1999	Zweig et al.		
		WO 99/12021	03/11/1999	Han		
		WO 99/13099	03/18/1999	Hughes et al.		
		WO 99/13100	03/18/1999	Forrow et al.		
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		WO 99/29230	06/17/1999	Bonnecaze et		
		WO 99/30152	06/17/1999	Crismore et al.		

Examiner Signature	Date Considered	

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Substitute for form 1449A/PTO				Application Number	10/688,561			
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003			
ST	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke			
				Group Art Unit	3736			
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_	U.S. PATENT DOCUMENTS								
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initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear				
		6,284,550	09/04/2001	Carroll et al.					
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Initials* No.	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/32881	07/01/1999	Beaty et al.		
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Examiner Signature	Date Considered	

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Substitute	for form 1449A/F	10		Application Number	10/688,561		
INFO	INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Filing Date	October 17, 2003		
STA				First Named Inventor	David W. Burke		
		_		Group Art Unit	3736		
(u.	(use as many sheets as necessary)			Examiner Name			
Sheet	22	of	38	Attornev Docket Number	7404-556		

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Examiner Initials*	Cite No.1	Document Number	Publication Date	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant	
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		WO 00/33074	06/08/2000	Lewis et al.		

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Substitute	e for form 1449A/F	10		Application Number	10/688,561		
INF	INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Filing Date	October 17, 2003		
STA				First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	23	of	38	Attornev Docket Number	7404-556		

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	No.¹	Number-Kind Code ² (If known)	MM-DD-TTTT	Application of Cited Document	Figures Appear	
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Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document		
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Substitut	e for form 1449A/F	10		Application Number 10/688,561			
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
ST	STATEMENT BY APPLICANT (use as many sheets as necessary)			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	24	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS		
Examiner	Cite	Document Number	Publication Date	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant	
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Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document		
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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,561		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
ST	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
,				Group Art Unit	3736		
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Sheet	25	of	38	Attornev Docket Number	7404-556		

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant		
Initials*	No.1	Number-Kind Code ² (if known)	MM-DD-YYYY	Application of Cited Document	Figures Appear		
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	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	т
	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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				Application Number	10/688,561		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	26	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS		
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear	
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
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Substitute for form 1449A/PTO				Complete if Known			
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	ORMATION			Filing Date	October 17, 2003		
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
			,	Group Art Unit	3736		
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Sheet	28	of	38	Attornev Docket Number	7404-556		

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Initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number Complete if Known Substitute for form 1449A/PTO 10/688,561 **Application Number** INFORMATION DISCLOSURE October 17, 2003 Filing Date STATEMENT BY APPLICANT David W. Burke First Named Inventor 3736 **Group Art Unit** (use as many sheets as necessary) **Examiner Name** 7404-556 Attorney Docket Number of Sheet

			U.S. PATEN	U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear					
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	 	WO 02/070734 A1	09/12/2002	Modzelewski et		
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		Group Art Unit	3736	
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Substitute	for form 1449A/F	10		Application Number	10/688,561		
INFO	DRMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	TEMENT BY	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003	
STA	ATEMENT B	BY AP	PLICANT	First Named Inventor	David W. Burke	
				Group Art Unit	3736	
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		WO 02/49507	06/27/2002	Stiene et al.		
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		WO 02/103343 A1	12/27/2002	Nakaminami et		
		WO 03/005015	01/16/2003	Bae et al.		_
		WO 03/012422	02/13/2003	Cai et al.		$oldsymbol{ol}}}}}}}}}}}}}}}}}$
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-		6,676,995	01/13/2004	Dick et al.					
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		WO 03/015629	02/27/2003	Moerman et al.		
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	`	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS						
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<u></u>	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS							
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INFO	RMATION	DISCL	OSURE	Filing Date	October 17, 2003			
STAT	EMENT E	BY APPI	LICANT	First Named Inventor	David W. Burke			
				Group Art Unit	3736			
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Sheet	37	of	38	Attorney Docket Number	7404-556			

		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	,				
Examiner Initials*	Cite No.1	Cite No. Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, serial, symposium, catalog, etc.), date, page(s), volume-Issue number(s) publisher city and/or country where publish					
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STAT	CEMENT E	3Y APPI	LICANT	First Named Inventor	David W. Burke		
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Sheet	38	of	38	Attorney Docket Number	7404-556		

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